

Notice of References Cited	Application/Control No. 10/540,774		Applicant(s)/Patent Under Reexamination KARATSU ET AL.	
	Examiner Melvin C. Mayes		Art Unit 1791	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2006/0096693	05-2006	Murosawa et al.	156/089.12
*	B	US-7,014,725	03-2006	Nagai et al.	156/89.11
*	C	US-3,138,610	06-1964	BUC DOLORES M; et. al.	548/314.7
*	D	US-2006/0180269	08-2006	Karatsu et al.	156/230
*	E	US-2006/0254701	11-2006	Murosawa et al.	156/235
*	F	US-2006/0035072	02-2006	Abe et al.	428/325
*	G	US-2003/0037857	02-2003	Burdon et al.	156/89.11
*	H	US-2006/0191443	08-2006	Yamaguchi et al.	106/640
*	I	US-2006/0130320	06-2006	Murosawa et al.	029/829
*	J	US-7,318,874	01-2008	Roosen et al.	156/89.11
*	K	US-5,089,071	02-1992	Tominaga et al.	156/89.17
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	2002-84056	03-2002	JP	-----	-----
	O	03/036667	05-2003	WO	-----	-----
	P	2001-60528	03-2001	JP	-----	-----
	Q	2000-357625	12-2000	JP	-----	-----
	R	2000-332385	11-2000	JP	-----	-----
	S	02/074715	09-2002	WO	-----	-----
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
	W				
	X				

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